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(54) A cleaning solution and its use for cleaning silicon semiconductors and silicon oxides.

(57) A cleaning solution for achieving highly accurate cleaning of silicon semiconductors and silicon oxides. The solution which enables a great reduction in the metal contaminants and the number of fine particles adhered on the surfaces and retention of the hydrophilic property of the surfaces to prevent the surfaces from being unstable, comprising an aqueous acidic solution containing 0.005 % by weight or more to less than 0.05 % by weight hydrogen fluoride and 0.3 % by weight or more to 20.0 % by weight or less hydrogen peroxide and having a pH in the range from 1 or more to less than 5.

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EUROPEAN SEARCH REPORT

Application Number
EP 94 11 6404

DOCUMENTS CONSIDERED TO BE RELEVANT			
Category	Citation of document with indication, where appropriate, of relevant passages	Relevant to claim	CLASSIFICATION OF THE APPLICATION (Int.Cl.6)
Y	IEEE TRANSACTIONS ON SEMICONDUCTOR MANUFACTURING, vol. 5, no. 2, May 1992 NEW YORK US, pages 114-120, XP 000360141 ITANO ET AL 'Particle deposition and removal in wet cleaning processes for ULSI manufacturing' * abstract *	1-4	H01L21/306
Y	EP-A-0 501 492 (OKMETIC OY) * claims *	1-4	
Y	EXTENDED ABSTRACTS, vol. 87, no. 1, 1887 PRINCETON, NEW JERSEY US, pages 381-382, LAMPERT 'Influence of the cleaning method on the chemical behaviour of hydrophilic silicon surfaces' * the whole document *	1-4	
A	JOURNAL OF THE ELECTROCHEMICAL SOCIETY, vol. 139, no. 6, June 1992 MANCHESTER, NEW HAMPSHIRE US, pages 1751-1756, XP 000324426 ANTTILA ET AL 'Metal contamination removal on silicon wafers using dilute acidic solutions' * abstract *	1-4	TECHNICAL FIELDS SEARCHED (Int.Cl.6) H01L
A	EP-A-0 477 504 (IBM) * abstract *	1-4	
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The present search report has been drawn up for all claims			
Place of search THE HAGUE		Date of completion of the search 13 June 1995	Examiner Gori, P
CATEGORY OF CITED DOCUMENTS			
X : particularly relevant if taken alone Y : particularly relevant if combined with another document of the same category A : technological background O : non-written disclosure P : intermediate document		T : theory or principle underlying the invention E : earlier patent document, but published on, or after the filing date D : document cited in the application L : document cited for other reasons & : member of the same patent family, corresponding document	



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EUROPEAN SEARCH REPORT

Application Number
EP 94 11 6404

DOCUMENTS CONSIDERED TO BE RELEVANT		
Category	Citation of document with indication, where appropriate, of relevant passages	Relevant to claim
A	IEEE TRANSACTIONS ON SEMICONDUCTOR MANUFACTURING, vol. 6, no. 3, August 1993 NEW YORK US, pages 258-267, XP 000399828 ITANO ET AL 'Particle removal from silicon wafer surface in wet cleaning process' * abstract *	1-4
A	PATENT ABSTRACTS OF JAPAN vol. 15 no. 498 (E-1146), 17 December 1991 & JP-A-03 218015 (TOSHIBA) * abstract *	1-4
		TECHNICAL FIELDS SEARCHED (Int.Cl.6)
The present search report has been drawn up for all claims		
Place of search	Date of completion of the search	Examiner
THE HAGUE	13 June 1995	Gori, P
CATEGORY OF CITED DOCUMENTS X : particularly relevant if taken alone Y : particularly relevant if combined with another document of the same category A : technological background O : non-written disclosure P : intermediate document T : theory or principle underlying the invention E : earlier patent document, but published on, or after the filing date D : document cited in the application L : document cited for other reasons & : member of the same patent family, corresponding document		